

FORM PTO-1449 INFORMATION DISCLOSURE STATEMENT BY APPLICANT (37 CFR 1.98(b))	ATTY. DOCKET NO. CU-3674	SERIAL NO. 10/812,795
	APPLICANT Masahiro SAITO et al	
	FILING DATE March 30, 2004	GROUP 2622

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUB- CLASS	FILING DATE IF APPROPRIATE

U.S. PUBLICATION DOCUMENTS

EXAMINER INITIAL	PUBL. NUMBER	PUBL. DATE	INVENTOR	CLASS	SUB- CLASS	FILING DATE IF APPROPRIATE
/AC/	US2004 0017501	Jan. 29, 2004	Asaga, Jun et al	/	/	

FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

EXAMINER INITIAL	DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY OR PATENT OFFICE	CLASS	SUB- CLASS	TRANSLATION YES I NO
/AC/	2001 - 188155	July 10, 2001	Japan	/	/	

OTHER DOCUMENTS (Including Author, Title, Date, Place of publication)

EXAMINER	/Albert Cutler/	DATE CONSIDERED 06/22/2007
EXAMINER: Initial citation considered. Draw line through citation if not In conformance and not considered. Include copy of this form with next communication to applicant.		



-3-

Form PTO-1449 (Modified)

FORM PTO-1449	ATTY. DOCKET NO. CU-3674	SERIAL NO. 10/812,795
INFORMATION DISCLOSURE STATEMENT BY APPLICANT	APPLICANT Masahiro Saito et al.	
(37 CFR 1.98(b))	FILING DATE March 30, 2004	GROUP 2614

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUB- CLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

EXAMINER INITIAL	DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY OR PATENT OFFICE	CLASS	SUB- CLASS	TRANSLATION YES NO
/AC/	JP60 - 2 0 6 3 7 7	10-17-85	JAPAN			
/AC/	JP2002 - 2 2 9 1 1 0	08-14-02	JAPAN			
/AC/	JP2001 - 3 3 3 3 2 2	11-30-01	JAPAN			
/AC/	JP2001 - 1 9 6 5 6 8	07-19-01	JAPAN			
/AC/	JP1 - 1 9 7 7 0 8	08-09-89	JAPAN			
/AC/	EP 1 2 2 3 7 4 9	07-17-02	EPO			
/AC/	EP 0 5 8 5 1 8 6	03-02-94	EPO			

OTHER DOCUMENTS (Including Author, Title, Date, Place of publication)

/AC/	PATENT ABSTRACT OF JAPAN for JP-60-206377
/AC/	PATENT ABSTRACT OF JAPAN for JP-2002-229110
/AC/	PATENT ABSTRACT OF JAPAN for JP-2001-333322
/AC/	PATENT ABSTRACT OF JAPAN for JP-2001-196568
/AC/	PATENT ABSTRACT OF JAPAN for JP-1-197708
EXAMINER /Albert Cutler/	DATE CONSIDERED 06/22/2007
EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

(Form PTO-1449)